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Front Matter: Volume 7328

, "Front Matter: Volume 7328," Proc. SPIE 7328, Enhanced and Synthetic Vision 2009, 732801 (20 May 2009); doi: 10.1117/12.833836

SPIE.

Event: SPIE Defense, Security, and Sensing, 2009, Orlando, Florida, United States

PROCEEDINGS OF SPIE

Enhanced and Synthetic Vision 2009

**Jeff J. Güell
Maarten Uijt de Haag**
Editors

**14 April 2009
Orlando, Florida, United States**

Sponsored and Published by
SPIE

Volume 7328

Proceedings of SPIE, 0277-786X, v. 7328

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Author(s), "Title of Paper," in *Enhanced and Synthetic Vision 2009*, edited by Jeff J. G,ell, Maarten Uijt de Haag, Proceedings of SPIE Vol. 7328 (SPIE, Bellingham, WA, 2009) Article CID Number.

ISSN 0277-786X

ISBN 9780819475947

Published by

SPIE

P.O. Box 10, Bellingham, Washington 98227-0010 USA

Telephone +1 360 676 3290 (Pacific Time) · Fax +1 360 647 1445

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Printed in the United States of America.

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Introduction

This is the 15th volume of the series of conferences on Enhanced and Synthetic Vision.

After the first two proceedings volumes numbered 2220 (in 1994) and 2463 (in 1995), the proceedings volumes were systematically titled "Enhanced and Synthetic Vision YEAR," where YEAR stands for the year the conference was held: Proceedings of SPIE Vols. 2736 (1996), 3088 (1997), 3364 (1998), 3691 (1999), 4023 (2000), 4363 (2001), 4713 (2002), 5081 (2003), 5424 (2004), 5802 (2005), 6226 (2006), 6559 (2007), and 6957 (2008).

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